

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/003,040	<b>Applicant(s)/Patent under Reexamination</b> GOOD ET AL.
	<b>Examiner</b> MINH-CHAU N. NGUYEN	<b>Art Unit</b> 2145

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner